

September 2010

FDMC7672S

N-Channel Power Trench[®] SyncFETTM 30 V, 14.8 A, 6.0 m Ω

Features

- Max $r_{DS(on)}$ = 6.0 m Ω at V_{GS} = 10 V, I_D = 14.8 A
- Max $r_{DS(on)}$ = 7.1 m Ω at V_{GS} = 4.5 V, I_D = 12.4 A
- High performance technology for extremely low r_{DS(on)}
- Termination is Lead-free and RoHS Compliant

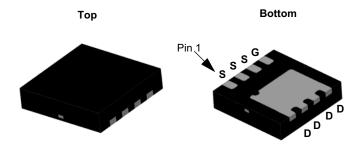


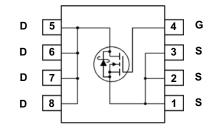
General Description

This FDMC7672S is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery packs.

Applications

- DC DC Buck Converters
- Notebook battery power mangement
- Load switch in Notebook





MLP 3.3x3.3

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			30	V
V _{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		18	
I _D	-Continuous	T _A = 25 °C	(Note 1a)	14.8	Α
	-Pulsed			45	7
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	60	mJ
D	Power Dissipation	T _C = 25 °C		36	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.3	
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		3.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	53	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC7672S	FDMC7672S	MLP 3.3X3.3	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25 °C		12		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	mA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA

On Characteristics (Note 2)

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1 \text{ mA}$	1.2	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25 °C		-6		mV/°C
		V _{GS} = 10 V, I _D = 14.8 A		5.0	6.0	
rno()	Static Drain to Source On Resistance	V _{GS} = 4.5 V, I _D = 12.4 A		6.1	7.1	mΩ
r _{DS(on)}		V_{GS} = 10 V, I_{D} = 14.8 A T_{J} = 125 °C		5.9	9.0	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 14.8 A		78		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45.V.V 0.V	1895	2520	pF
C _{oss}	Output Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	770	1025	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	85	130	pF
R _a	Gate Resistance		1.2	3.2	Ω

Switching Characteristics

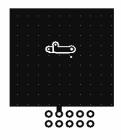
t _{d(on)}	Turn-On Delay Time		11	21	ns
t _r	Rise Time	V_{DD} = 15 V, I_{D} = 14.8 A, V_{GS} = 10 V, R_{GEN} = 6 Ω	4	10	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	26	42	ns
t _f	Fall Time		3	10	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	30	42	nC
Q_g	Total Gate Charge	V _{GS} = 0 V to 4.5 V V _{DD} = 15 V	14	20	nC
Q_{gs}	Gate to Source Gate Charge	I _D = 14.8 A	5.3		nC
Q_{gd}	Gate to Drain "Miller" Charge		4.0		nC

Drain-Source Diode Characteristics

V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 14.8 A (Note 2)	0.8	1.3	\/
	Source to Drain Diode Torward voltage	V _{GS} = 0 V, I _S = 1.9 A (Note 2)	0.5	1.2	\ \ \ \ \ \
t _{rr}	Reverse Recovery Time	I _E = 14.8 A, di/dt = 300 A/μs	29	45	ns
Q _{rr}	Reverse Recovery Charge	11 _F = 14.6 A, αι/αι = 300 A/μs	28	44	nC

Notes

^{1.} R_{0JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in^2 pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

^{3.} E_{AS} of 60 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 11 A, V_{DD} = 27 V, V_{GS} = 10 V. 100% test at L = 3 mH, I_{AS} = 4.8 A.

Typical Characteristics T_J = 25 °C unless otherwise noted

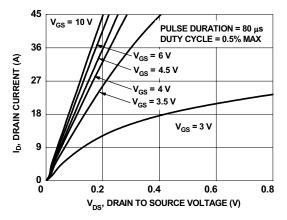


Figure 1. On-Region Characteristics

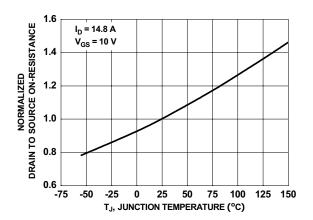


Figure 3. Normalized On-Resistance vs Junction Temperature

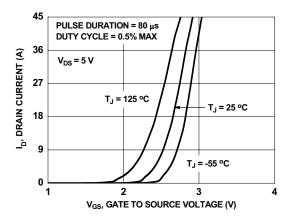


Figure 5. Transfer Characteristics

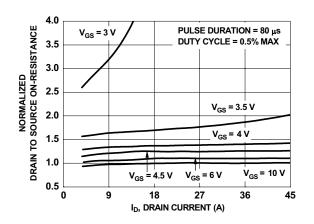


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

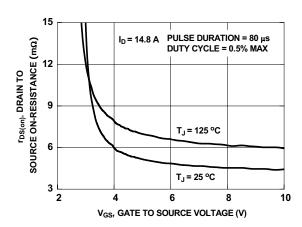


Figure 4. On-Resistance vs Gate to Source Voltage

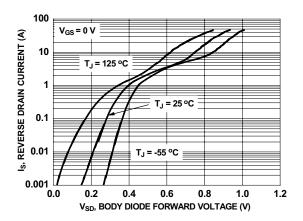


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

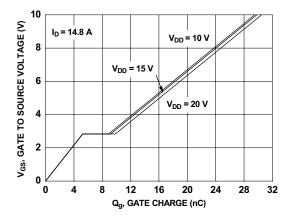


Figure 7. Gate Charge Characteristics

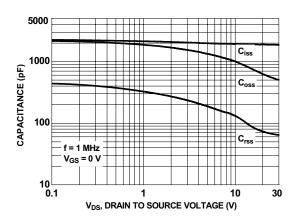


Figure 8. Capacitance vs Drain to Source Voltage

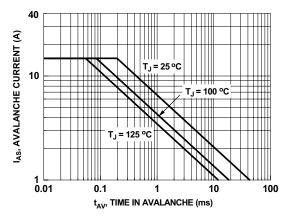


Figure 9. Unclamped Inductive Switching Capability

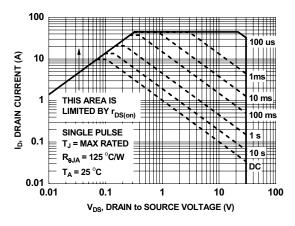


Figure 10. Forward Bias Safe Operating Area

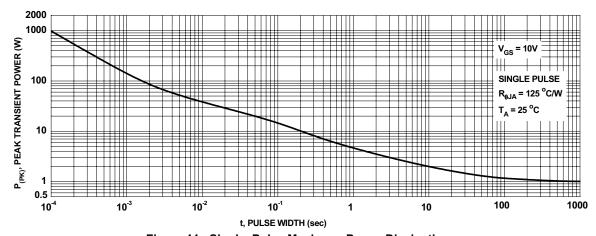


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

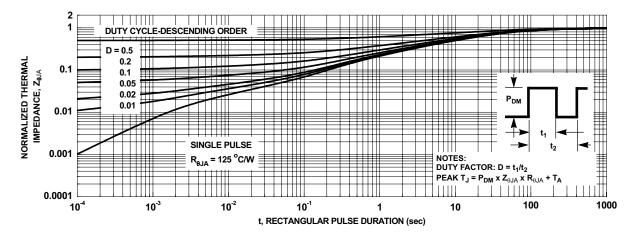


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 13 shows the reverses recovery characteristic of the FDMC7672S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

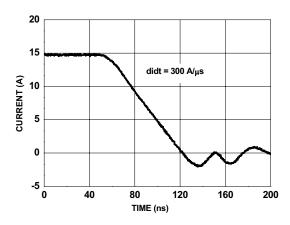


Figure 13. SyncFET body diode reverse recovery characteristic

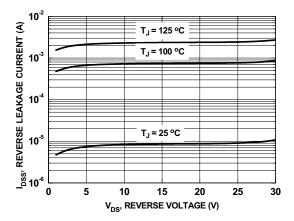
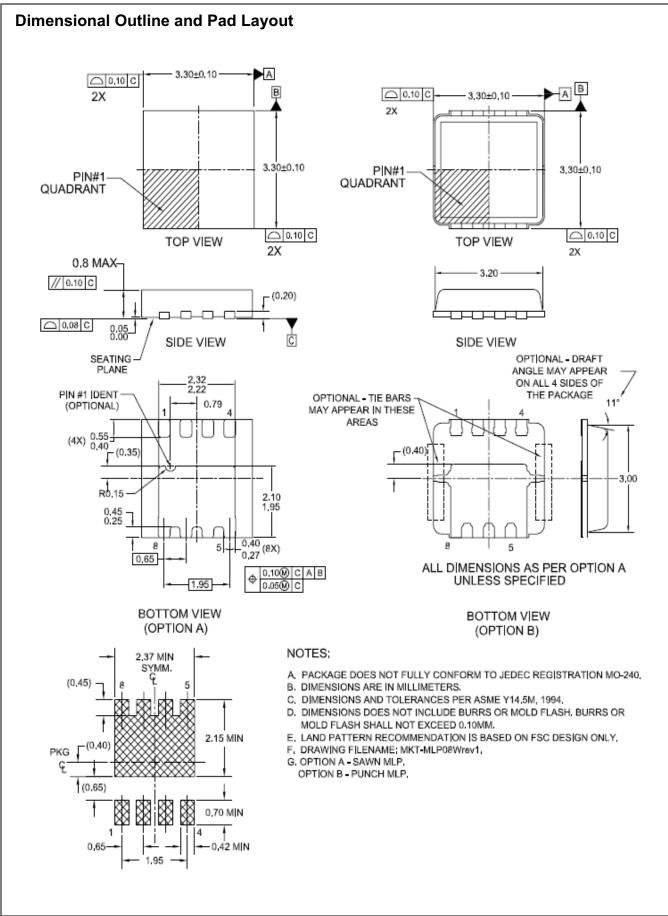


Figure 14. SyncFET body diode reverses leakage versus drain-source voltage







TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

 $\begin{array}{lll} \mathsf{AccuPower^{\mathsf{TM}}} & & \mathsf{F-PFS^{\mathsf{TM}}} \\ \mathsf{Auto-SPM^{\mathsf{TM}}} & & \mathsf{FRFET}^{\otimes} \\ \end{array}$

Build it NowTM Global Power Resource SM Glob

CorePLUS™ Green FPS™

CorePOWERTM Green FPSTM e-SeriesTM $CROSSVOLT^{TM}$ $Gmax^{TM}$ $CTLT^{TM}$ GTOTM

CTL™ GTO™

Current Transfer Logic™ IntelliMAX™

DEUXPEED® ISOPLANAR™

Dual Cool™ MegaBuck™

EcoSPARK® MICROCOUPLER™

EfficientMax™ MicroFET™

ESBC™ MicroPak™

ESBC™ **F**®

Fairchild®

Fairchild Semiconductor®

Fairchild Semiconductor®
FACT Quiet Series™
FACT®
FAST®
FAST®

FastvCore™ FETBench™ FlashWriter®*

FlashWriter®*
PDP SPMTM

Power-SPM™ PowerTrench® PowerXS™

Programmable Active Droop™

QFET[®]
QS[™]
Quiet Series[™]
RapidConfigure[™]

Saving our world, 1mW/W/kW at a time™

SignalWise™ SmartMax™ SMART START™ SPM®

STEALTH™
SUPERSOT™-3
SUPERSOT™-6
SUPERSOT™-8
SUPERSOT

Franchise
TinyBoost™
TinyBoost™
TinyCalc™
TinyLogic®
TINYOPTO™
TinyPower™
TinyPWM™
TinyPWM™
TinyPWIre™
TRUECURRENT™*
#SerDes™
UHC®
Ultra FRFET™

The Power Franchise®

Ultra FRFET UniFET™ VCX™ VisualMax™ XS™

* Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

MicroPak2™

MillerDrive™

MotionMax™

OptoHiT™

Motion-SPM™

OPTOLOGIC®

OPTOPLANAR®

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 148